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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE Docket No.: TRAN-P140.CIP
Thereby certify that this transmittal of the below described document is being deposited with the United States Postal Service in an envelope bearing First Class Postage and addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on the below date of deposit. Name of Person Making the Deposit: Date of Deposit: Signature of the Person Making the Deposit: 03/09/05 Judy Davenport Inventor(s): Shingo Suzuki Serial No.: 10/672,793 **Group Art Unit:** 2829 Filed: 09/26/03 Examiner: Hollington, J.M. Confirmation No: 9465 Title: SYSTEM AND METHOD FOR MEASURING TRANSISTOR LEAKAGE CURRENT WITH A RING OSCILLATOR WITH BACKBIAS CONTROLS Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450 Sir: TRANSMITTAL OF FORMAL DRAWINGS In response to Drawing Informalities attached please find: the formal drawings for this application Number of Sheets 16 Each sheet of drawing indicates the identifying indicia suggested in § 1.84(c) on the reverse side of the drawing a copy of the NOTICE OF INFORMAL DRAWINGS

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Respectfully submitted,

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